

## Microwave Linear Transistors

The TRW linear devices described herein are medium signal (1.5 watt), common emitter, diffused ballasted, **gold metalized** microwave transistors characterized for Class « A » service.

Because of TRW's proprietary ballasting and other protection techniques, no special techniques are required to protect these devices from arbitrary terminations up to infinite VSWR (any phase) so long as the transistors are attached properly to an adequate heat sink.

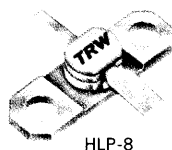
These transistors are useful for a variety of Military and industrial applications. They are available in TRW's HLP-8 flange package (TRW 52601), the HLP-8 flangeless (TRW 52101) and the new TW-200 symmetrically opposed emitter stripline package (TRW 52001).

Particular attention is directed to the ultralinear properties of these transistors and the guaranteed specification in accordance with DIN-45004.

Complete mechanical and electrical data are contained herein.

### Electrical Characteristics ( $T_{\text{flange}} = 25\text{ }^{\circ}\text{C}$ )

1.5 W  
2 GHz  
CLASS "A"

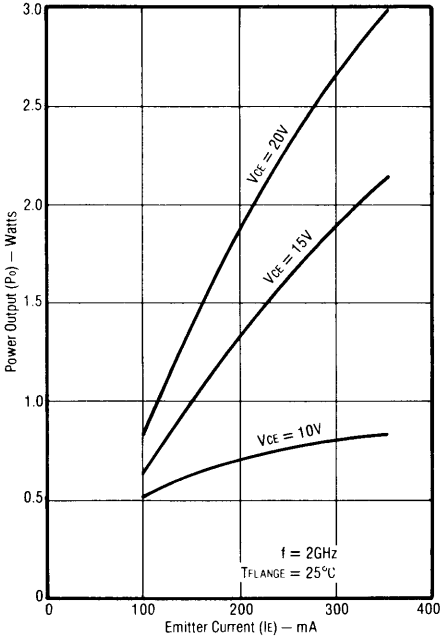


HLP-8

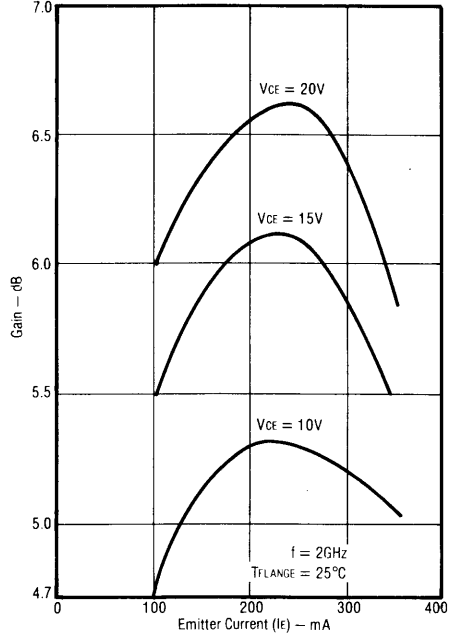
	SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
D C Tests	$BV_{CEO}$	Collector-Emitter Breakdown Voltage	$I_C = 20\text{ mA}$	24			V
	$BV_{CER}$	Collector-Emitter Breakdown Voltage	$R_{BE} = 10\ \Omega, I_C = 20\text{ mA}$	50			V
	$BV_{EBO}$	Emitter-Base Breakdown Voltage	$I_E = 0.25\text{ mA}$	3.5			V
	$BV_{CBO}$	Collector-Base Breakdown Voltage	$I_C = 1.0\text{ mA}$	45			V
	$I_{CBO}$	Collector Cutoff Current	$V_{CB} = 28\text{ V}$			0.125	mA
	$h_{FE}$	Forward Current Transfer Ratio	$V_{CE} = 5.0\text{ V}, I_C = 100\text{ mA}$	20		120	—
R F Tests	$C_{ob}$	Collector-Base Capacitance	$V_{CB} = 28\text{ V}, f = 1\text{ MHz}$			5	pF
	$P_o$	Power Output	$V_{CE} = 20\text{ V}, I_E = 220\text{ mA}$ $f = 2.0\text{ GHz}, P_{in} = 0.375\text{ W}$	1.5			W
	$f_t$	Frequency Cutoff	$V_{CE} = 20\text{ V}, I_E = 220\text{ mA}$	2.7	3.0		GHz
	VSWR	Mismatch Tolerance	$P_o = 1.5\text{ W}, I_E = 220\text{ mA}, V_{CE} = 20\text{ V}$	$\infty$			
	IMD	Third Order intermodulation Distortion (Reference to Either Tone)	$V_{CE} = 20\text{ V}, I_E = 220\text{ mA}$ $f = 2.0\text{ GHz}, P_{o(PEP)} = 1.5\text{ W}$ Tones at 2.05 GHz and 2.1 GHz			-30	dB
	$IMD_{(TV)}$	Intermodulation per DIN-45004/K	$V_{CE} = 20\text{ V}, I_E = 150\text{ mA}$ $f = 1.0\text{ GHz}, P_{REF} = 0.5\text{ W}$			-60	dB
Operating	$T_j$ & $T_{stg}$	Max Junction and Storage Temperature		-65		+200	$^{\circ}\text{C}$
	$\theta_{jC}$	Thermal Resistance	$T_C = 25\text{ }^{\circ}\text{C}$			15	$^{\circ}\text{C/W}$

**ELECTRICAL CHARACTERISTICS**  
 TRW52001, TRW52101, TRW52601

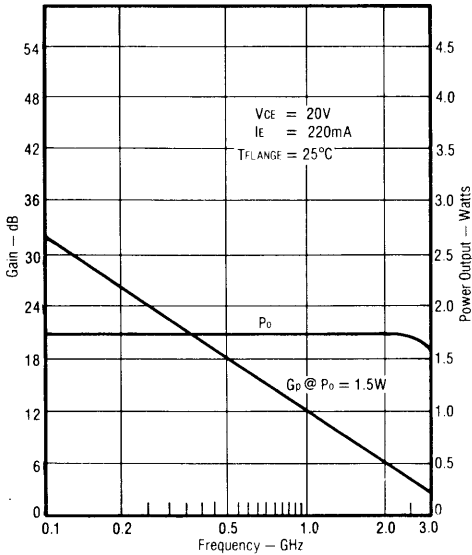
**1dB Compression Point vs. Emitter Current**



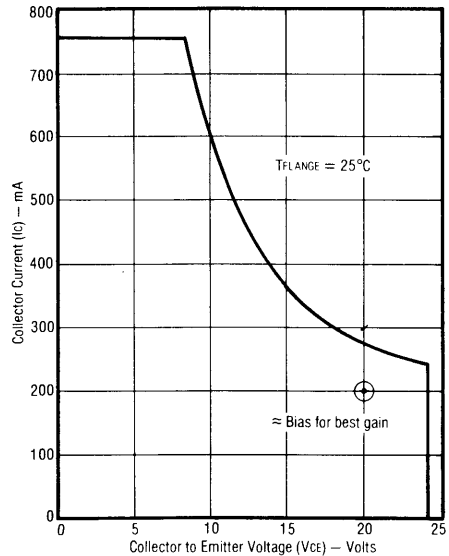
**Gain vs. Emitter Current**



**Gain and 1dB Compressed Power vs. Frequency**

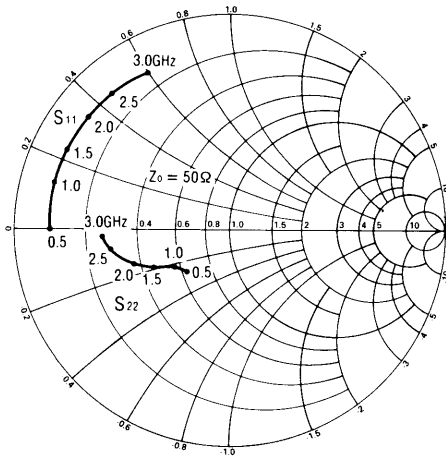


**Safe Operating Area**

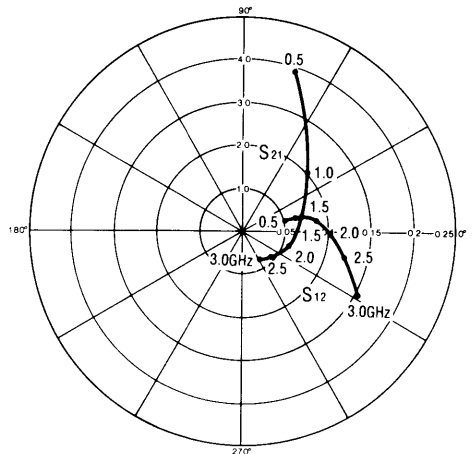
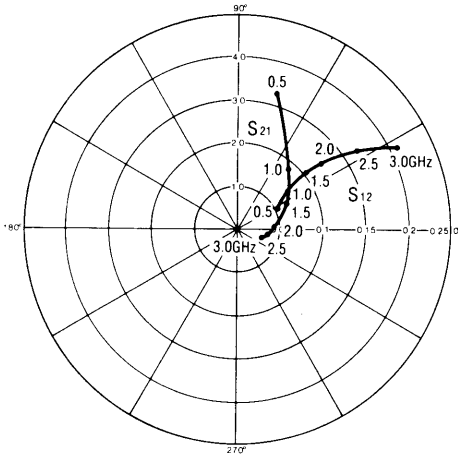
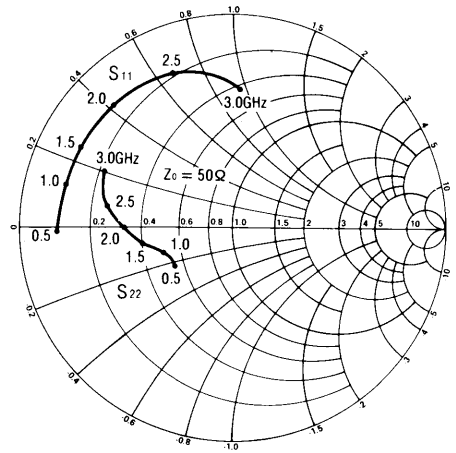


**S-PARAMETERS**  
 $V_{CE} = 20V, I_E = 220mA, T_{FLANGE} = 25^{\circ}C$

TRW52001

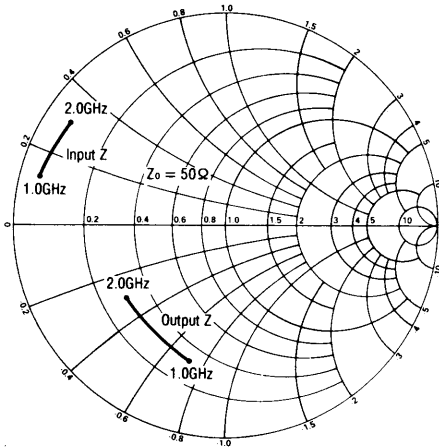


TRW52101, TRW52601

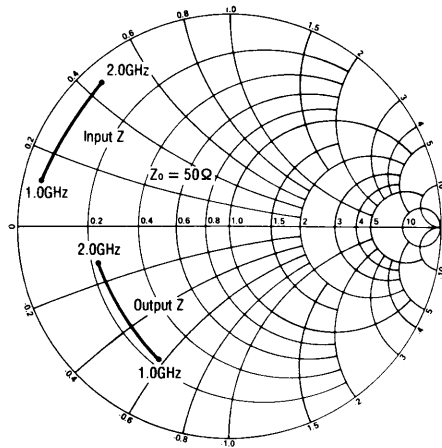


**LARGE SIGNAL IMPEDANCE DATA**  
 $V_{CE} = 20V, I_E = 220mA, T_{FLANGE} = 25^{\circ}C$

TRW52001

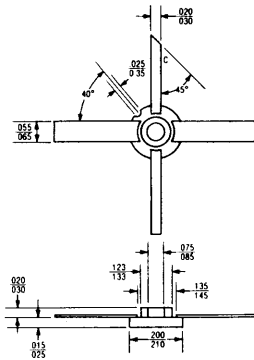


TRW52101, TRW52601

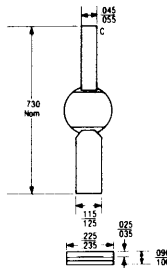


**Package Outlines**

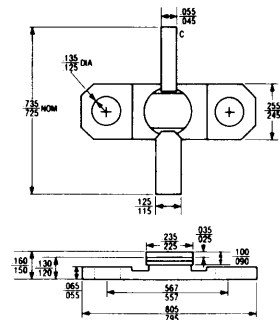
TRW52001



TRW52101



TRW52601



**Mechanical Specifications**

The following are mechanical specifications for this transistor series.

Dimensions: Per outline drawing.

Solderability: Per MIL-STD-750.

Marking: Per MIL-S-19500, "TRW," 4-digit date code, type number.

Hermeticity: Per MIL-STD-750,  $10^{-7}$  atmospheres gross and

fine leak. (Available on special order screened to  $10^{-8}$  atmospheres.)

Acceleration: Per MIL-STD-750, 20,000G in any plane.

Lead Pull: Per MIL-STD-750, 3 grams min.

Package: A brazed ceramic package assuring long-term integrity of hermetic seals. Leads of KOVAR base material with minimum 60 microinches of gold plating.

## Microwave Linear Transistors

The TRW linear devices described herein are medium signal (3.0 watt), common emitter, diffused ballasted **gold metalized** microwave transistors characterized for Class « A » service. Because of TRW's proprietary ballasting and other protection techniques, no special techniques are required to protect these devices from arbitrary terminations up to infinite VSWR (any phase) so long as the transistors are attached properly to an adequate heat sink.

These transistors are useful for a variety of Military and industrial applications. They are available in TRW's HLP-8 flange package (TRW 52602), the HLP-8 flangeless (TRW 52102).

Particular attention is directed to the ultralinear properties of these transistors and the guaranteed specification in accordance with DIN-45004.

Complete mechanical and electrical data are contained herein.

3 W  
2 GHz  
CLASS "A"



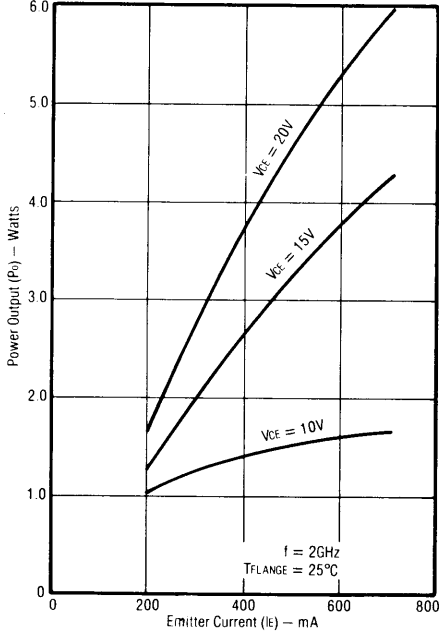
HLP-8

### Electrical Characteristics ( $T_{\text{flange}} = 25\text{ }^{\circ}\text{C}$ )

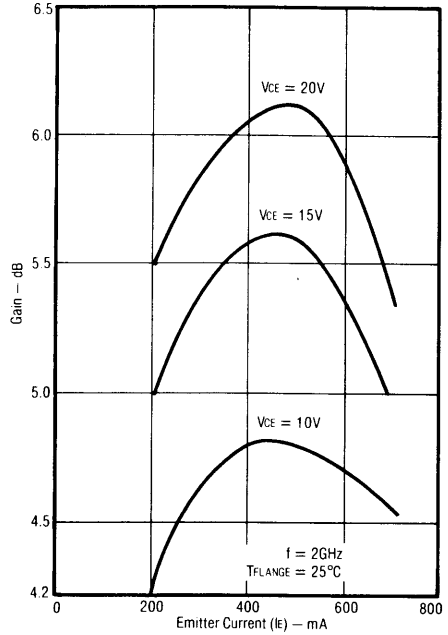
	SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
DC Tests	$BV_{CEO}$	Collector-Emitter Breakdown Voltage	$I_C = 40\text{ mA}$	24			V
	$BV_{CER}$	Collector-Emitter Breakdown Voltage	$R_{BE} = 10\ \Omega, I_C = 40\text{ mA}$	50			V
	$BV_{EBO}$	Emitter-Base Breakdown Voltage	$I_E = 0.50\text{ mA}$	3.5			V
	$BV_{CBO}$	Collector-Base Breakdown Voltage	$I_C = 2.0\text{ mA}$	45			V
	$I_{CBO}$	Collector Cutoff Current	$V_{CB} = 28\text{ V}$			0.25	mA
	$h_{FE}$	Forward Current Transfer Ratio	$V_{CE} = 5.0\text{ V}, I_C = 200\text{ mA}$	20		120	—
R F Tests	$C_{ob}$	Collector-Base Capacitance	$V_{CB} = 28\text{ V}, f = 1\text{ MHz}$			7	pF
	$P_o$	Power Output	$V_{CE} = 20\text{ V}, I_E = 440\text{ mA}$ $f = 2.0\text{ GHz}, P_{in} = 0.75\text{ W}$	3.0			W
	$f_t$	Frequency Cutoff	$V_{CE} = 20\text{ V}, I_E = 440\text{ mA}$	2.7	3.0		GHz
	VSWR	Mismatch Tolerance	$P_o = 3.0\text{ W}, I_E = 440\text{ mA}, V_{CE} = 20\text{ V}$	$\infty$			
	IMD	Third Order Intermodulation Distortion	$V_{CE} = 20\text{ V}, I_E = 440\text{ mA}$ $P_{o(PEP)} = 3.0\text{ W}$ Tones at 2.000 GHz and 2.005 GHz			-30	dB
	IMD <sub>(TV)</sub>	Intermodulation per DIN-45004/K	$V_{CE} = 20\text{ V}, I_E = 300\text{ mA}$ $f = 1.0\text{ GHz}, P_{REF} = 1.0\text{ W}$			-60	dB
Operating	$T_j$ & $T_{stg}$	Max Junction and Storage Temperature		-65		+200	$^{\circ}\text{C}$
	$\theta_{j-c}$	Thermal Resistance	$25\text{ }^{\circ}\text{C}$			8.5	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS

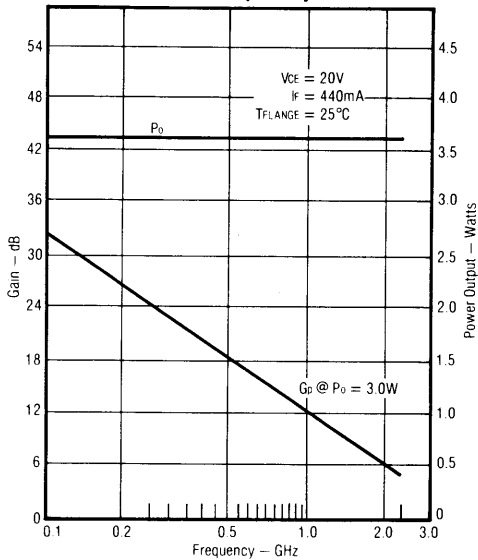
1dB Compression Point vs. Emitter Current



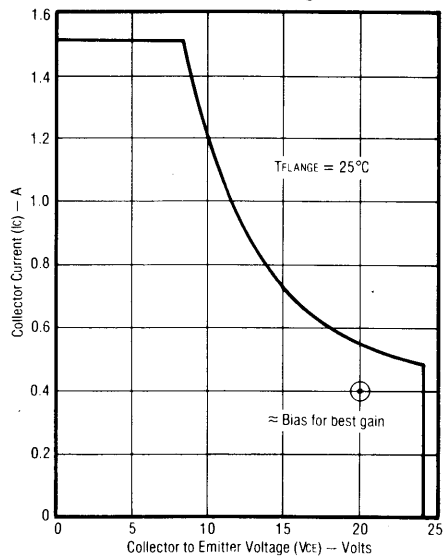
Gain vs. Emitter Current



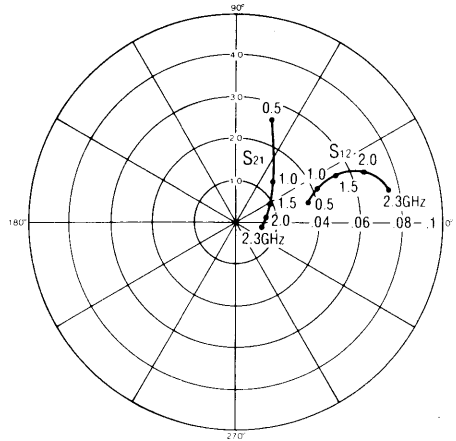
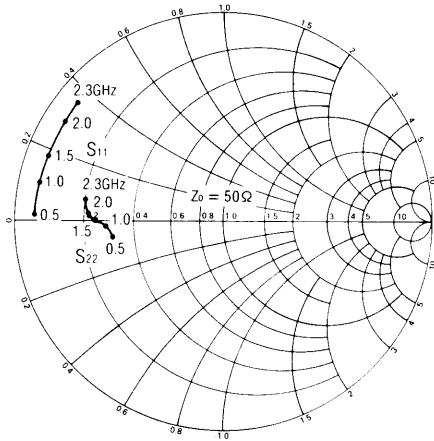
Gain and 1dB Compressed Power vs. Frequency



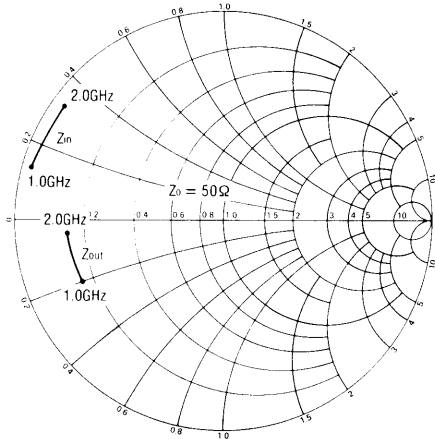
D.C. Safe Operating Area



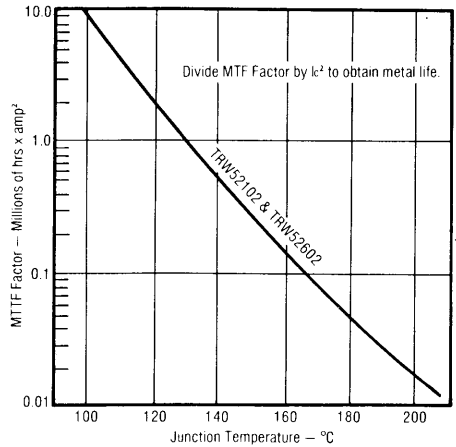
**S-PARAMETERS**  
 $V_{CE} = 20V, I_E = 440mA, T_{FLANGE} = 25^{\circ}C$



**Large Signal Impedance Data**



**MTTF Factor vs. Junction Temperature**







## Microwave Linear Transistors

The TRW linear devices described herein are medium signal (6.0 watt), common emitter, diffused ballasted, **gold metalized** microwave transistors characterized for Class « A » service.

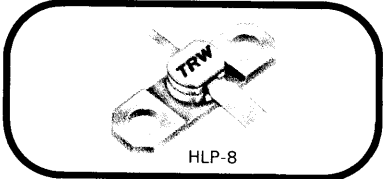
Because of TRW's proprietary ballasting and other protection techniques, no special techniques are required to protect these devices from arbitrary terminations up to infinite VSWR (any phase) so long as the transistors are attached properly to an adequate heat sink.

These transistors are useful for a variety of Military and industrial applications. They are available in TRW's HLP-8 flange package (TRW 52604), the HLP-8 flangeless (TRW 52104).

Particular attention is directed to the ultralinear properties of these transistors and the guaranteed specification in accordance with DIN-45004.

Complete mechanical and electrical data are contained herein.

**6 W**  
**2 GHz**  
**CLASS "A"**

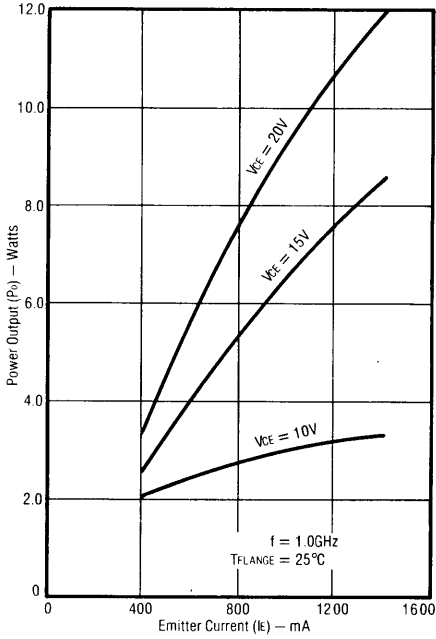


### Electrical Characteristics ( $T_{\text{flange}} = 25\text{ }^{\circ}\text{C}$ )

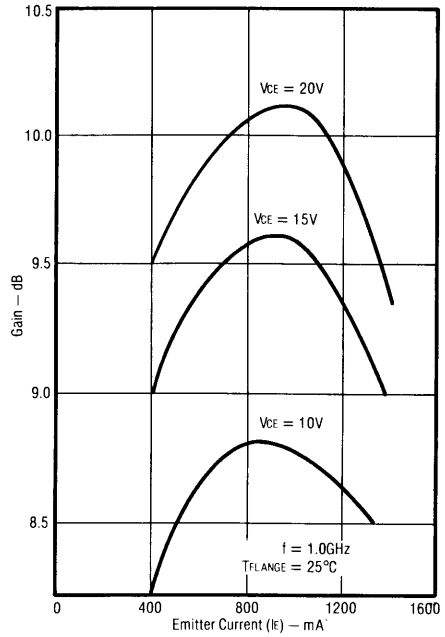
	SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
D C Tests	$BV_{CEO}$	Collector-Emitter Breakdown Voltage	$I_C = 80\text{ mA}$	24			V
	$BV_{CER}$	Collector-Emitter Breakdown Voltage	$R_{BE} = 10\ \Omega, I_C = 80\text{ mA}$	50			V
	$BV_{EBO}$	Emitter-Base Breakdown Voltage	$I_E = 1.0\text{ mA}$	3.5			V
	$BV_{CBO}$	Collector-Base Breakdown Voltage	$I_C = 4.0\text{ mA}$	45			V
	$I_{CBO}$	Collector Cutoff Current	$V_{CB} = 28\text{ V}$			0.5	mA
	$h_{FE}$	Forward Current Transfer Ratio	$V_{CE} = 5.0\text{ V}, I_C = 400\text{ mA}$	20		120	—
R F Tests	$C_{ob}$	Collector-Base Capacitance	$V_{CB} = 28\text{ V}, f = 1\text{ MHz}$			12	pF
	$P_o$	Power Output	$V_{CE} = 20\text{ V}, I_E = 880\text{ mA}$ $f = 1.0\text{ GHz}, P_{in} = 0.600\text{ W}$	6.0			W
	$f_t$	Frequency Cutoff	$V_{CE} = 20\text{ V}, I_E = 880\text{ mA}$	2.4	2.6		GHz
	VSWR	Mismatch Tolerance	$P_o = 5.0\text{ W}, I_E = 600\text{ mA}, V_{CE} = 20\text{ V}$	3:1			
	IMD	Third Order Intermodulation Distortion	$V_{CE} = 20\text{ V}, I_E = 880\text{ mA}$ $P_{o(PEP)} = 6.0\text{ W}$ Tones at 1.000 GHz and 1.005 GHz			— 30	dB
	IMD <sub>(TV)</sub>	Intermodulation per DIN-45004/K	$V_{CE} = 20\text{ V}, I_E = 600\text{ mA}$ $f = 1.0\text{ GHz}, P_{REF} = 2.0\text{ W}$			— 60	dB
Operating	$T_j$ & $T_{sig}$	Max Junction and Storage Temperature		— 65		+ 200	$^{\circ}\text{C}$
	$\theta_{j-c}$	Thermal Resistance	$P_o = 5\text{ W}, V_{CE} = 20\text{ V}, I_E = 880\text{ mA}$			6.0	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS

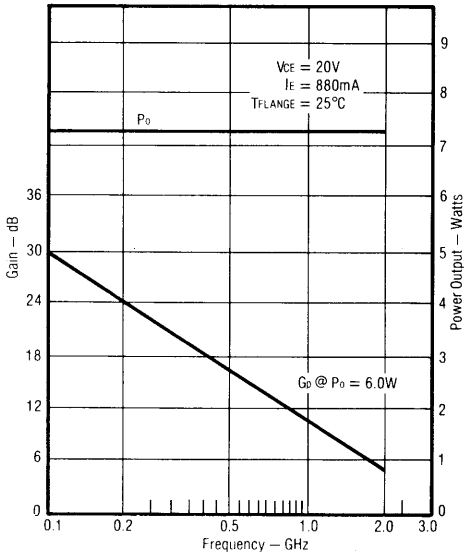
1dB Compression Point vs. Emitter Current



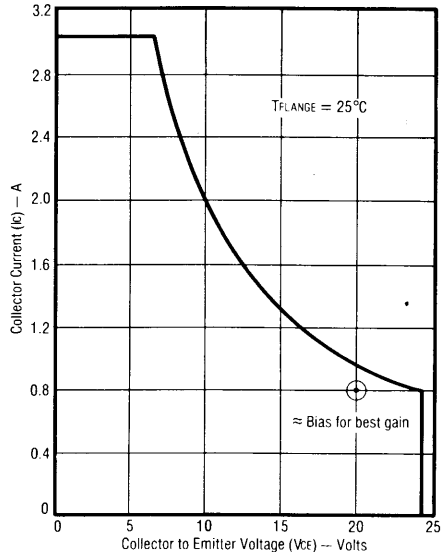
Gain vs. Emitter Current



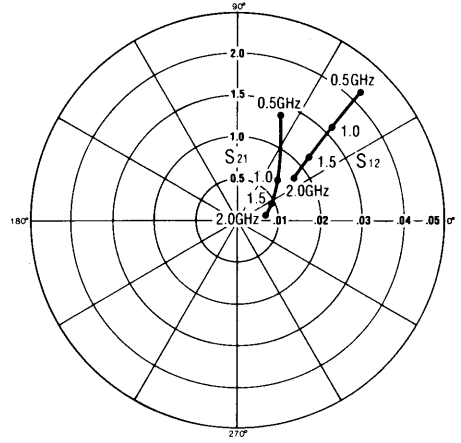
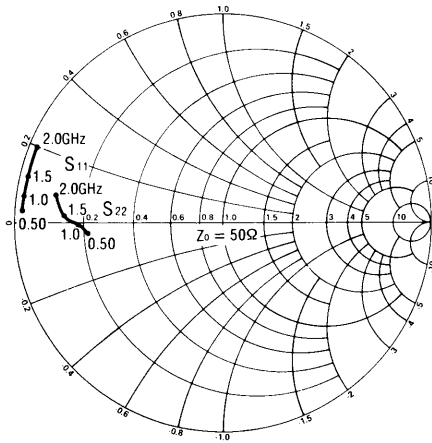
Gain and 1dB Compressed Power vs. Frequency



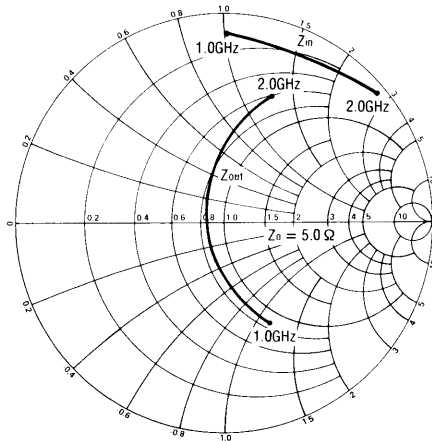
D.C. Safe Operating Area



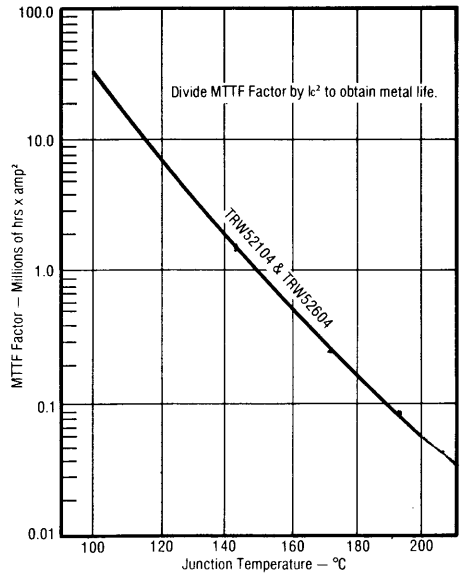
**S-Parameters**  
**V<sub>CE</sub> = 20V, I<sub>E</sub> = 880mA, T<sub>FLANGE</sub> = 25°C**



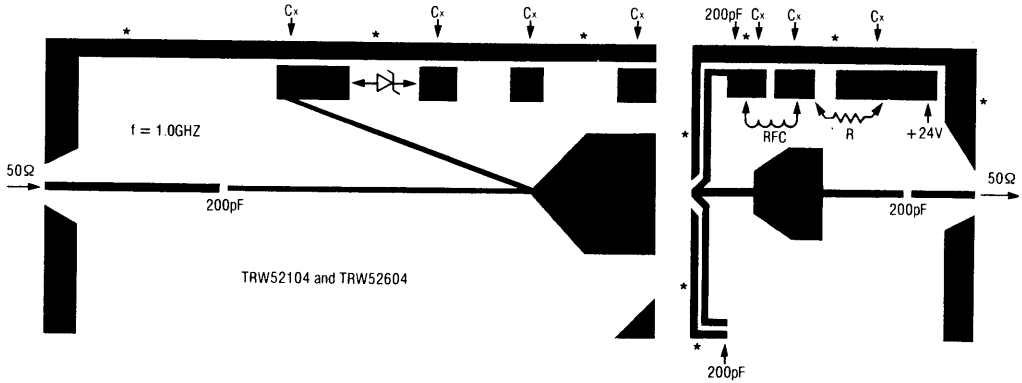
**Large Signal Impedance Data**



**MTTF Factor vs. Junction Temperature**



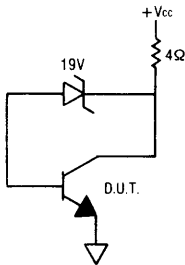
TEST CIRCUIT BOARD FOR TRW52104 AND TRW52604



Parts Details

- \* = Foil-wrap asterisked edge to ground plane. Board material 0.020 inch glass-teflon  $\epsilon_r = 2.55$ .
- $C_x$  = 100pF and 0.1 $\mu$ F chip
- Zener Diode = 19V, 1W
- RFC = 8 turns, #28A.W.G., 0.040 diameter
- R = 4 $\Omega$ , 4W

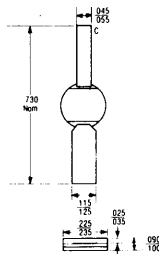
Self-Regulating Bias Circuit



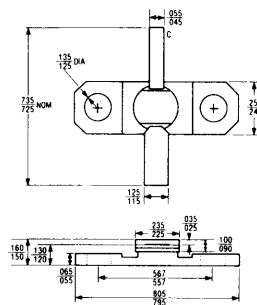
Set  $V_{cc}$  for desired  $I_E$   
 $V_{CE} \approx V_Z + 1$

Package Outlines

TRW52104



TRW52604



Mechanical Specifications

The following are mechanical specifications for this transistor series.

- Dimensions: Per outline drawing.
- Solderability: Per MIL-STD-750.
- Marking: Per MIL-S-19500, "TRW," 4-digit date code, type number.
- Hermeticity: Per MIL-STD-750,  $10^{-7}$  atmospheres gross and

fine leak. (Available on special order screened to  $10^{-8}$  atmospheres.)

- Acceleration: Per MIL-STD-750, 20,000G in any plane.
- Bond Pull: Per MIL-STD-750, 3 grams min.
- Package: A brazed ceramic package assuring long-term integrity of hermetic seals. Leads of KOVAR base material with minimum 60 microinches of gold plating.

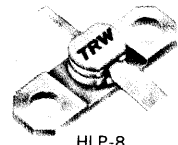
## Microwave Linear Transistors

The TRW linear devices described herein are medium signal (0.8 watt), common emitter, diffused ballasted, **gold metalized** microwave transistors characterized for Class « A » service. Because of TRW's proprietary ballasting and other protection techniques, no special techniques are required to protect these devices from arbitrary terminations up to infinite VSWR (any phase) so long as the transistors are attached properly to an adequate heat sink.

These transistors are useful for a variety of Military and industrial applications. They are available in TRW's HLP-8 flange package (TRW 53601), the HLP-8 flangeless (TRW 53101) and the new TW-200 symmetrically opposed emitter stripline package (TRW 53001).

Particular attention is directed to the ultralinear properties of these transistors and the guaranteed specification in accordance with DIN-45004. Complete mechanical and electrical data are contained herein.

0.8 W  
3 GHz  
CLASS "A"



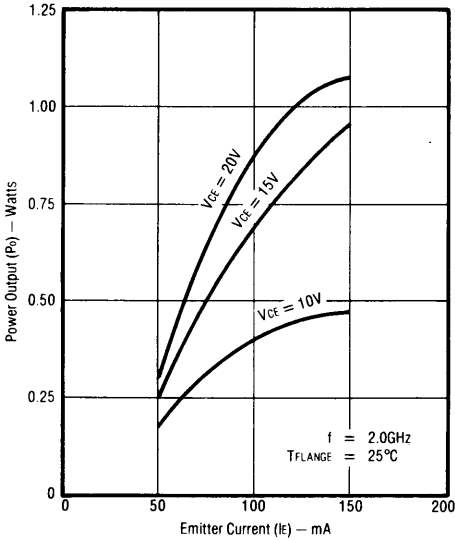
HLP-8

### Electrical Characteristics ( $T_{\text{flange}} = 25\text{ }^{\circ}\text{C}$ )

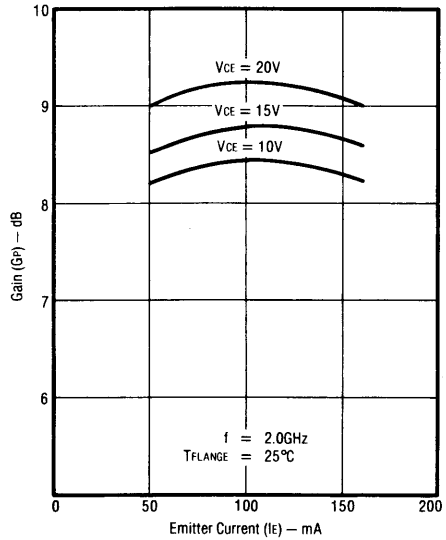
	SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
D C Tests	$BV_{\text{CEO}}$	Collector-Emitter Breakdown Voltage	$I_{\text{C}} = 10\text{ mA}$	24			V
	$BV_{\text{CER}}$	Collector-Emitter Breakdown Voltage	$R_{\text{BE}} = 10\ \Omega, I_{\text{C}} = 10\text{ mA}$	50			V
	$BV_{\text{EBO}}$	Emitter-Base Breakdown Voltage	$I_{\text{E}} = 0.25\text{ mA}$	3.5			V
	$BV_{\text{CBO}}$	Collector-Base Breakdown Voltage	$I_{\text{C}} = 1.0\text{ mA}$	45			V
	$I_{\text{CBO}}$	Collector Cutoff Current	$V_{\text{CB}} = 28\text{ V}$			0.25	mA
	$h_{\text{FE}}$	Forward Current Transfer Ratio	$V_{\text{CE}} = 5.0\text{ V}, I_{\text{C}} = 100\text{ mA}$	20		120	—
R F Tests	$C_{\text{ob}}$	Collector-Base Capacitance	$V_{\text{CB}} = 28\text{ V}, f = 1\text{ MHz}$			3.5	pF
	$P_{\text{o}}$	Power Output	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 120\text{ mA}$ $f = 2.0\text{ GHz}, P_{\text{in}} = 0.113\text{ W}$	0.8			W
	$f_{\text{t}}$	Frequency Cutoff	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 120\text{ mA}$	3.0	3.3		GHz
	VSWR	Mismatch Tolerance	$P_{\text{o}} = 0.8\text{ W}, I_{\text{E}} = 120\text{ mA}, V_{\text{CE}} = 20\text{ V}$	$\infty$			
	IMD	Third Order Intermodulation Distortion (Reference to Either Tone)	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 120\text{ mA}$ $P_{\text{o(PEP)}} = 0.8\text{ W}$ Tones at 2.000 GHz and 2.005 GHz			— 30	dB
	IMD <sub>(TV)</sub>	Intermodulation per DIN-45004/K	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 75\text{ mA}$ $f = 1.0\text{ GHz}, P_{\text{REF}} = 0.25\text{ W}$			— 60	dB
Operating	$T_{\text{j}}$ & $T_{\text{stg}}$	Max Junction and Storage Temperature		— 65		+ 200	$^{\circ}\text{C}$
	$\theta_{\text{jF}}$	Thermal Resistance	$T_{\text{C}} = 25\text{ }^{\circ}\text{C}$			31	$^{\circ}\text{C/W}$

**Electrical Characteristics**  
**TRW53001, TRW53101, TRW53601**

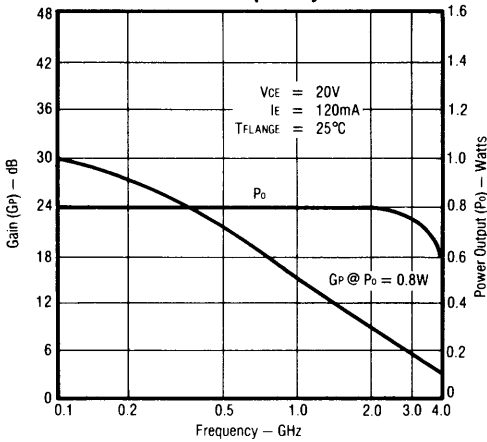
**1dB Compression Point vs. Emitter Current**



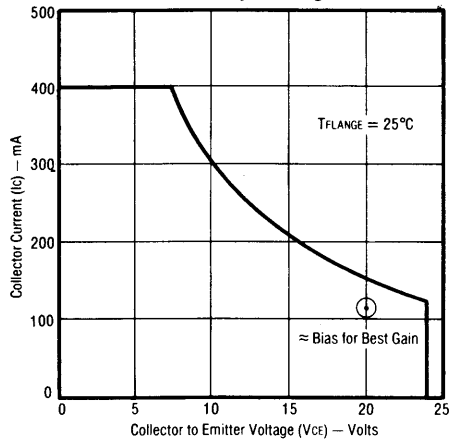
**Gain vs. Emitter Current**



**Gain and 1dB Compressed Power vs. Frequency**



**D.C. Safe Operating Area**



**Mechanical Specifications**

The following are mechanical specifications for this transistor series.

- Dimensions: Per outline drawing.
- Solderability: Per MIL-STD-750.
- Marking: Per MIL-S-19500, "TRW," 4-digit date code, type number.
- Hermeticity: Per MIL-STD 750,  $10^{-7}$  atmospheres gross and

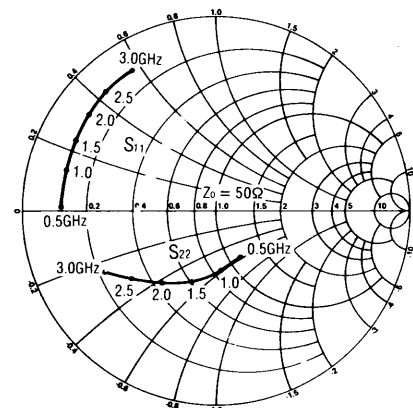
fine leak. (Available on special order screened to  $10^{-8}$  atmospheres.)

- Acceleration: Per MIL-STD-750, 20,000G in any plane.
- Bond Pull: Per MIL-STD-750, 3 grams min.
- Package: A brazed ceramic package assuring long-term integrity of hermetic seals. Leads of KOVAR base material with minimum 60 microinches of gold plating.

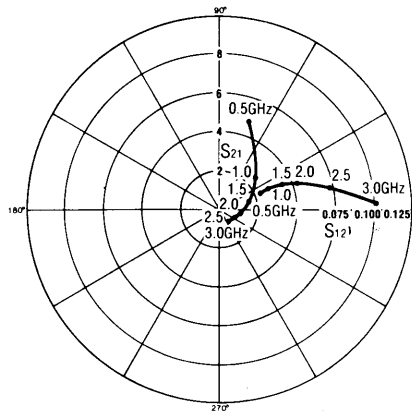
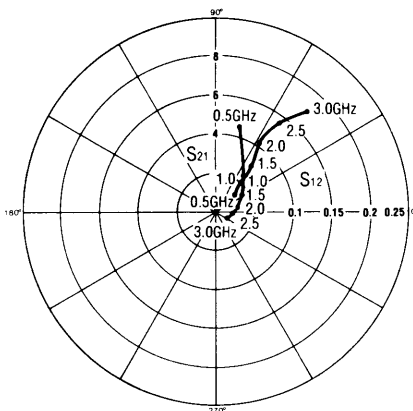
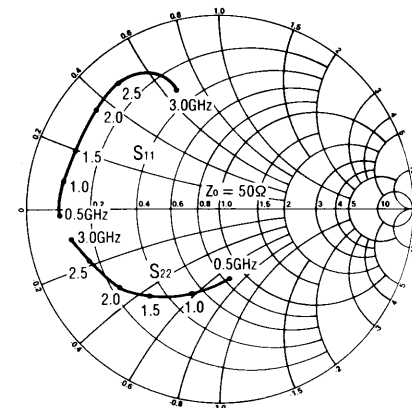
S-Parameters

$V_{CE} = 20V, I_E = 120mA, T_{FLANGE} = 25^\circ C$

TRW53001

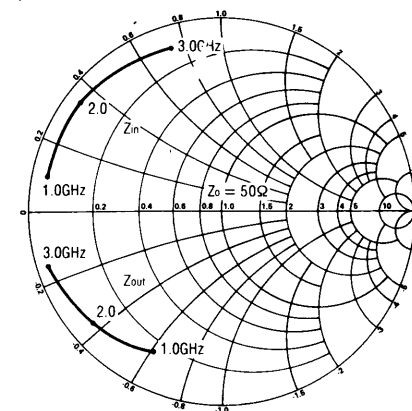
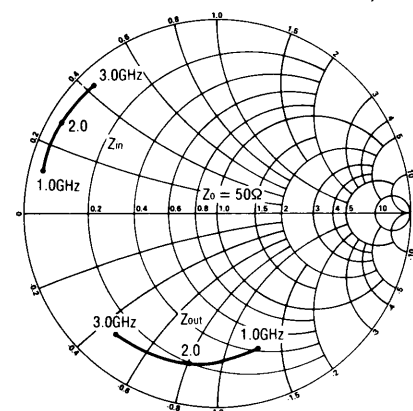


TRW53101, TRW53601

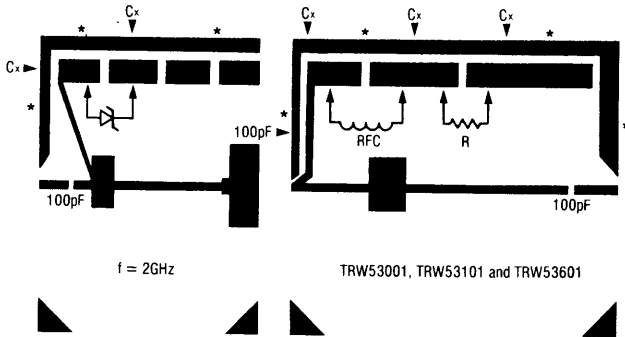


Large Signal Impedance Data

$V_{CE} = 20V, I_E = 120mA, T_{FLANGE} = 25^\circ C$



**Test Circuit Board For  
TRW53001, TRW53101 AND TRW53601**



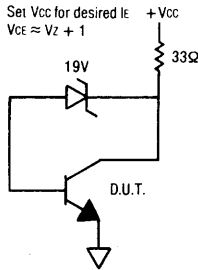
f = 2GHz

TRW53001, TRW53101 and TRW53601

**Parts Details**

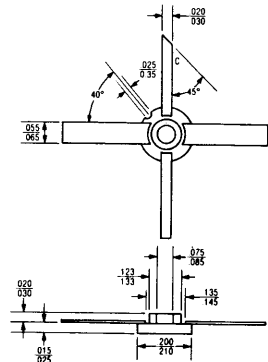
- \* = Foil-wrap asterisked edge to ground plane. Board material 0.020 inch glass-  
teflon  $\epsilon_r = 2.55$ .
- Cx = 100pF and 0.1  $\mu$ F chip
- Zener Diode = 19V, 1W
- RFC = 8 turns, #28A.W.G., 0.040 diameter
- R = 33 $\Omega$ , 1W

**Self-Regulating  
Bias Circuit**

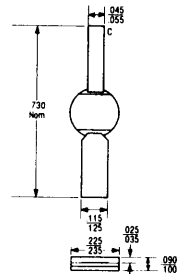


**Package Outlines**

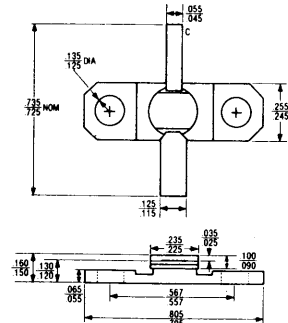
**TRW53001**



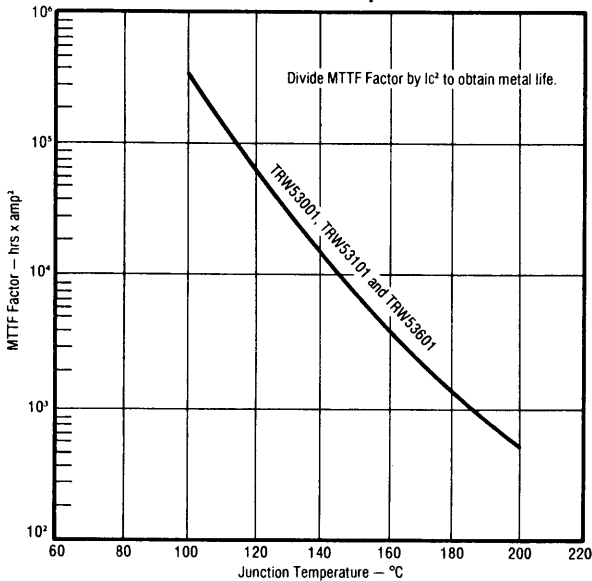
**TRW53101**



**TRW53601**



**MTTF Factor  
vs. Junction Temperature**





## Microwave Linear Transistors

The TRW linear devices described herein are medium signal (1.6 watt), common emitter, diffused ballasted, **gold metalized** microwave transistors characterized for Class « A » service.

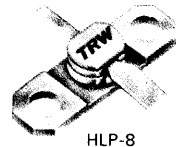
Because of TRW's proprietary ballasting and other protection techniques, no special techniques are required to protect these devices from arbitrary terminations up to infinite VSWR (any phase) so long as the transistors are attached properly to an adequate heat sink.

These transistors are useful for a variety of Military and industrial applications. They are available in TRW's HLP-8 flange package (TRW 53602), the HLP-8 flangeless (TRW 53102).

Particular attention is directed to the ultralinear properties of these transistors and the guaranteed specification in accordance with DIN-45004.

Complete mechanical and electrical data are contained herein.

1.6 W  
3 GHz  
CLASS "A"

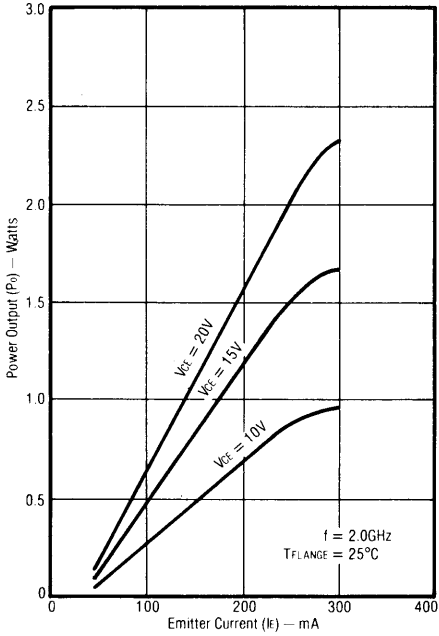


### Electrical Characteristics ( $T_{\text{flange}} = 25\text{ }^{\circ}\text{C}$ )

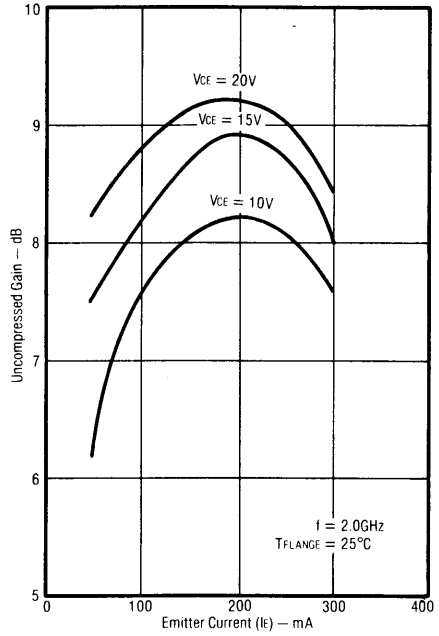
	SYMBOL	CHARACTERISTICS	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
D C Tests	$BV_{\text{CEO}}$	Collector-Emitter Breakdown Voltage	$I_{\text{C}} = 20\text{ mA}$	24			V
	$BV_{\text{CER}}$	Collector-Emitter Breakdown Voltage	$R_{\text{BE}} = 10\ \Omega, I_{\text{C}} = 20\text{ mA}$	50			V
	$BV_{\text{EBO}}$	Emitter-Base Breakdown Voltage	$I_{\text{E}} = 0.50\text{ mA}$	3.5			V
	$BV_{\text{CBO}}$	Collector-Base Breakdown Voltage	$I_{\text{C}} = 2.0\text{ mA}$	45			V
	$I_{\text{CBO}}$	Collector Cutoff Current	$V_{\text{CB}} = 28\text{ V}$			0.5	mA
	$h_{\text{FE}}$	Forward Current Transfer Ratio	$V_{\text{CE}} = 5.0\text{ V}, I_{\text{C}} = 200\text{ mA}$	20		120	—
R F Tests	$C_{\text{ob}}$	Collector-Base Capacitance	$V_{\text{CB}} = 28\text{ V}, f = 1\text{ MHz}$			5.5	pF
	$P_{\text{o}}$	Power Output	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 230\text{ mA}$ $f = 2.0\text{ GHz}, P_{\text{in}} = 0.253\text{ W}$	1.6			W
	$f_{\text{t}}$	Frequency Cutoff	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 230\text{ mA}$	3.0	3.3		GHz
	VSWR	Mismatch Tolerance	$P_{\text{o}} = 1.6\text{ W}, I_{\text{E}} = 230\text{ mA}, V_{\text{CE}} = 20\text{ V}$	$\infty$			
	IMD	Third Order Intermodulation Distortion (Reference to Either Tone)	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 230\text{ mA}$ $P_{\text{o(PEP)}} = 1.6\text{ W}$ Tones at 2.000 GHz and 2.005 GHz			— 30	dB
	IMD <sub>(TV)</sub>	Intermodulation per DIN-45004/K	$V_{\text{CE}} = 20\text{ V}, I_{\text{E}} = 150\text{ mA}$ $f = 1.0\text{ GHz}, P_{\text{REF}} = 0.5\text{ W}$			— 60	dB
Operating	$T_{\text{j}} \text{ \& } T_{\text{sig}}$	Max Junction and Storage Temperature		— 65		+ 200	$^{\circ}\text{C}$
	$\theta_{\text{j-c}}$	Thermal Resistance	$T_{\text{C}} = 25\text{ }^{\circ}\text{C}$			17	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS

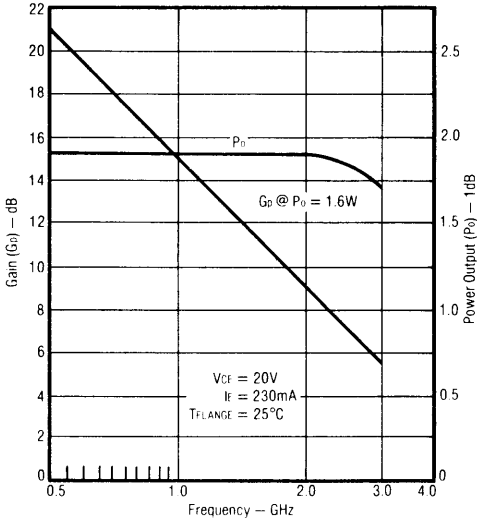
1dB Compression Point vs. Emitter Current



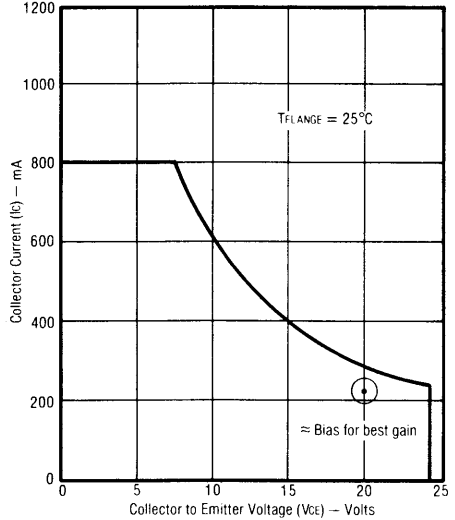
Gain vs. Emitter Current



Gain and 1dB Compressed Power vs. Frequency

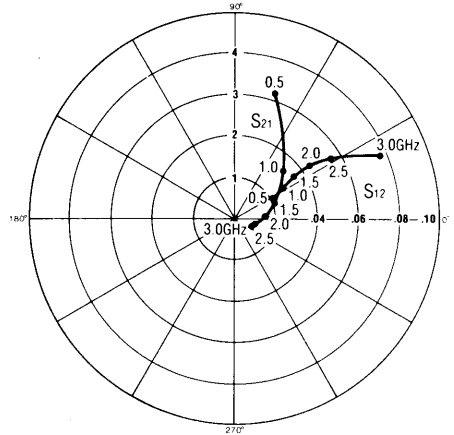
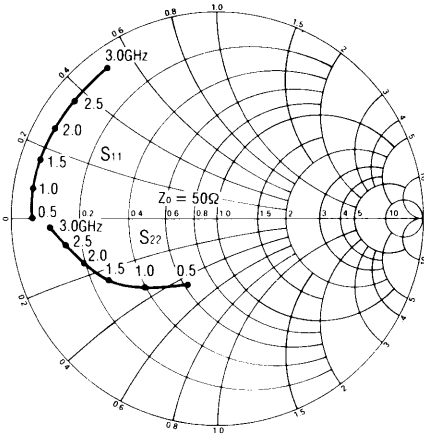


D.C. Safe Operating Area

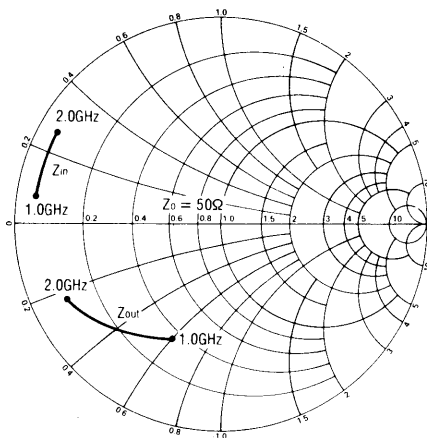


**S-PARAMETERS**

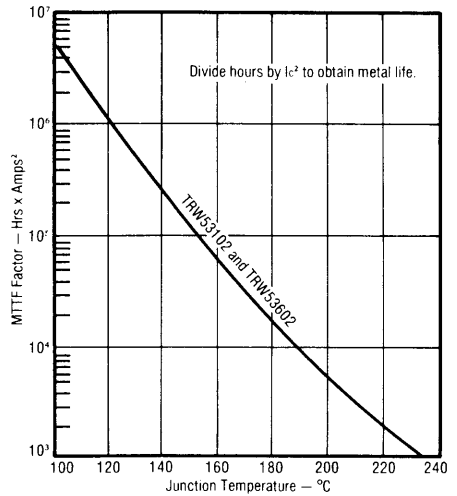
$V_{CE} = 20V, I_E = 230mA, T_{FLANGE} = 25^\circ C$



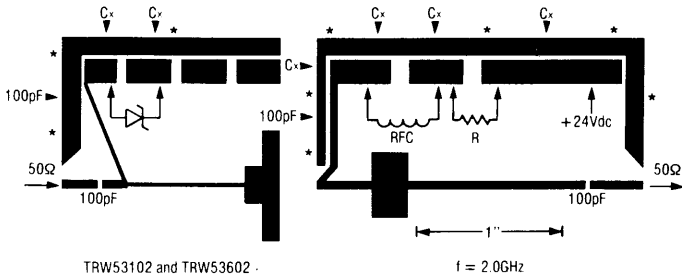
**Large Signal Impedance Data**



**MTTF Factor vs. Junction Temperature**



**TEST CIRCUIT BOARD FOR TRW53102 AND TRW53602**



**Parts Details**

\* = Foil-wrap asterisked edge to ground plane. Board material 0.020 inch glass-tylon  $\epsilon_r = 2.55$ .

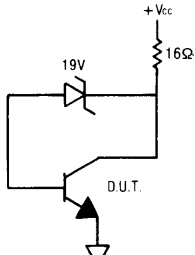
Cx = 100pF and 0.1 $\mu$ F chip

Zener Diode = 19V, 1W

RFC = 8 turns, #28A.W.G., 0.040 diameter

R = 16 $\Omega$ , 2W

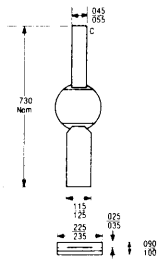
**Self-Regulating Bias Circuit**



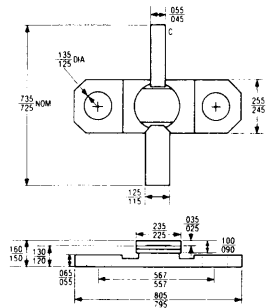
Set Vcc for desired Ie  
Vcc  $\approx$  Vz + 1

**Package Outlines**

**TRW53102**



**TRW53602**



**Mechanical Specifications**

The following are mechanical specifications for this transistor series.

Dimensions: Per outline drawing.

Solderability: Per MIL-STD-750.

Marking: Per MIL-S-19500, "TRW," 4 digit date code, type number.

Hermeticity: Per MIL-STD-750, 10<sup>-7</sup> atmospheres gross and

fine leak. (Available on special order screened to 10<sup>-8</sup> atmospheres.)

Acceleration: Per MIL-STD-750, 20,000G in any plane.

Bond Pull: Per MIL-STD-750, 3 grams min.

Package: A brazed ceramic package assuring long-term integrity of hermetic seals. Leads of KOVAR base material with minimum 60 microns of gold plating.